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SEP 13 2005

Practitioner's Docket No. MI22-2379

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

*In re application of:* Warren M. Farnworth, et al.

*Application No.:* 10/632,273

*Group No.:* 2829

*Filed:* July 31, 2003

*Examiner:* Russell M. Kobert

*Title:* Method and Apparatus for Testing Semiconductor Circuitry for Operability and Method of Forming Apparatus for Testing Semiconductor Circuitry for Operability

Commissioner for Patents  
Washington, D.C. 20231

CERTIFICATION OF FACSIMILE TRANSMISSION

I hereby certify that the following papers are being facsimile transmitted to the Patent and Trademark Office at (571) 273-8300 on the date shown below:

1. Facsimile Transmittal
2. Examiner Interview Summary of September 7, 2005

September 13, 2005  
Date

Julie A. Foster  
Julie A. Foster

Total Pages: 3

Although it is believed that no fees are due, the Commissioner is hereby authorized to charge any fees under 37 C.F.R. 1.16 and 1.17 which may be required by this paper to Deposit Account No. 23-0925.

(Certification of Facsimile Transmission--page 1 of 1)

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Application Serial No. 10/632,273  
Examiner Interview Summary of September 7, 2005

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. ....10/632,273  
Filing Date ..... July 31, 2003  
Inventor ..... Warren M. Farnworth, et al.  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 2829  
Examiner ..... Russell M. Kobert  
Attorney's Docket No. .... MI22-2379  
Customer No. .... 021567  
Title: Method and Apparatus for Testing Semiconductor Circuitry for Operability and  
Method of Forming Apparatus for Testing Semiconductor Circuitry for Operability

EXAMINER INTERVIEW SUMMARY OF SEPTEMBER 7, 2005

To: Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

From: D. Brent Kenady  
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Applicant's representative held an interview with Examiner Kobert on September 7, 2005. Applicant's representative would like to thank Examiner Kobert for his time and attention to this matter.

Applicant's representative directed Examiner's attention to the "selected portion of Figure 4" presented by the Examiner in the pending office action (pg. 3, paper no. 0605). Applicant's representative directed the Examiner's attention to an important inconsistency of the figure. That is, the figure illustrates an alleged "substrate (portion of 40)" and an

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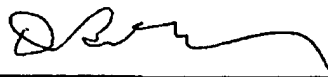
MI22-2379

alleged "lateral dimension of substrate" illustrated as a horizontal arrow which clearly does not correspond to a lateral dimension of the substrate. The Examiner stated he understood Applicant's position and encouraged the Applicant to describe the inconsistency in a subsequently-filed response. Applicant's representative stated he would do so.

Applicant's representative is greatly appreciative of Examiner Kobert's consideration of this matter.

Respectfully submitted,

Dated: 9-13-05

By:   
D. Brent Kenady  
Reg. No. 40,045